



## STD110NH02L

N-channel 24V - 0.0044Ω - 80A - DPAK  
STripFET™ III Power MOSFET

### General features

| Type        | V <sub>DS</sub> | R <sub>DS(on)</sub> | I <sub>D</sub>     |
|-------------|-----------------|---------------------|--------------------|
| STD110NH02L | 24V             | <0.0048Ω            | 80A <sup>(1)</sup> |

1. Value limited by wire bonding

- R<sub>DS(on)</sub> \* Qg industry's benchmark
- Conduction losses reduced
- Switching losses reduced
- Low threshold device

### Description

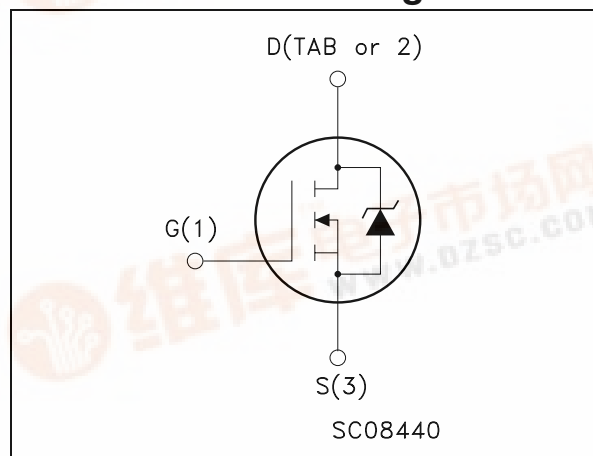
This device utilizes the latest advanced design rules of ST's proprietary STripFET™ technology. This is suitable for the most demanding DC-DC converter application where high efficiency is to be achieved.

### Applications

- Switching application



### Internal schematic diagram



### Order codes

| Part number   | Marking   | Package | Packaging   |
|---------------|-----------|---------|-------------|
| STD110NH02LT4 | D110NH02L | DPAK    | Tape & reel |

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# 1 Electrical ratings

**Table 1. Absolute maximum ratings**

| Symbol                   | Parameter  | Value      | Unit                  |
|--------------------------|--|------------|-----------------------|
| $V_{\text{spike}}^{(1)}$ | Drain-source voltage rating  | 30         | V                     |
| $V_{\text{DS}}$          | Drain-source voltage ( $V_{\text{GS}} = 0$ )                       | 24         | V                     |
| $V_{\text{DGR}}$         | Drain-gate voltage ( $R_{\text{GS}} = 20\text{K}\Omega$ )          | 24         | V                     |
| $V_{\text{GS}}$          | Drain-source voltage   | $\pm 20$   | V                     |
| $I_{\text{D}}^{(2)}$     | Drain current (continuous) at $T_{\text{C}} = 25^{\circ}\text{C}$  | 80         | A                     |
| $I_{\text{D}}^{(2)}$     | Drain current (continuous) at $T_{\text{C}} = 100^{\circ}\text{C}$ | 80         | A                     |
| $I_{\text{DM}}^{(3)}$    | Drain current (pulsed)   | 320        | A                     |
| $P_{\text{TOT}}$         | Total dissipation at $T_{\text{C}} = 25^{\circ}\text{C}$           | 125        | W                     |
|                          | Derating factor  | 0.83       | W/ $^{\circ}\text{C}$ |
| $E_{\text{AS}}^{(4)}$    | Single pulse avalanche energy                                      | 900        | mJ                    |
| $T_{\text{stg}}$         | Storage temperature  | -55 to 175 | $^{\circ}\text{C}$    |
| $T_{\text{J}}$           | Max. operating junction temperature                                |            |                       |

1. Guaranteed when external  $R_{\text{g}} = 4.7\ \Omega$  and  $t_{\text{f}} < t_{\text{fmax}}$ .
2. Value limited by wire bonding.
3. Pulse width limited by safe operating area
4. Starting  $T_{\text{J}} = 25^{\circ}\text{C}$ ,  $I_{\text{D}} = 30\text{A}$ ,  $V_{\text{DD}} = 15\text{V}$

**Table 2. Thermal data**

| Symbol            | Parameter                                      | Value | Unit                        |
|-------------------|--|-------|-----------------------------|
| $R_{\text{thJC}}$ | Thermal resistance junction-case Max           | 1.20  | $^{\circ}\text{C}/\text{W}$ |
| $R_{\text{thJA}}$ | Thermal resistance junction-ambient Max        | 100   | $^{\circ}\text{C}/\text{W}$ |
| $T_{\text{I}}$    | Maximum lead temperature for soldering purpose | 275   | $^{\circ}\text{C}$          |

## 2 Electrical characteristics

( $T_{CASE}=25^{\circ}\text{C}$  unless otherwise specified)

**Table 3. On<sup>(1)</sup> /off states**

| Symbol        | Parameter  | Test conditions   | Min. | Typ.             | Max.             | Unit                           |
|---------------|--|---|------|------------------|------------------|--------------------------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage                   | $I_D = 25\text{mA}$ , $V_{GS} = 0$  | 24   |                  |                  | V                              |
| $I_{DSS}$     | Zero gate voltage drain current ( $V_{GS} = 0$ ) | $V_{DS} = 20$<br>$V_{DS} = 20$ , $T_C = 125^{\circ}\text{C}$                            |      |                  | 1<br>10          | $\mu\text{A}$<br>$\mu\text{A}$ |
| $I_{GSS}$     | Gate body leakage current ( $V_{DS} = 0$ )       | $V_{GS} = \pm 20\text{V}$   |      |                  | $\pm 100$        | nA                             |
| $V_{GS(th)}$  | Gate threshold voltage                           | $V_{DS} = V_{GS}$ , $I_D = 250\mu\text{A}$  | 1    |                  |                  | V                              |
| $R_{DS(on)}$  | Static drain-source on resistance                | $V_{GS} = 10\text{V}$ , $I_D = 40\text{A}$<br>$V_{GS} = 5\text{V}$ , $I_D = 20\text{A}$ |      | 0.0044<br>0.0050 | 0.0050<br>0.0095 | $\Omega$<br>$\Omega$           |

1. Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

**Table 4. Dynamic**

| Symbol                              | Parameter   | Test conditions  | Min. | Typ.                | Max. | Unit           |
|-------------------------------------|---|--|------|---------------------|------|----------------|
| $g_{fs}^{(1)}$                      | Forward transconductance  | $V_{DS} = 10\text{V}$ , $I_D = 40\text{A}$                                   |      | 52                  |      | S              |
| $C_{iss}$<br>$C_{oss}$<br>$C_{rss}$ | Input capacitance<br>Output capacitance<br>Reverse transfer capacitance | $V_{DS} = 15\text{V}$ , $f = 1\text{MHz}$ ,<br>$V_{GS} = 0$                  |      | 4450<br>1126<br>141 |      | pF<br>pF<br>pF |
| $Q_g$<br>$Q_{gs}$<br>$Q_{gd}$       | Total gate charge<br>Gate-source charge<br>Gate-drain charge            | $V_{DD} = 10\text{V}$ , $I_D = 80\text{A}$<br>$V_{GS} = 10\text{V}$          |      | 69<br>13<br>9       | 93   | nC<br>nC<br>nC |
| $Q_{oss}^{(2)}$                     | Output charge   | $V_{DS} = 16\text{V}$ , $V_{GS} = 0\text{V}$                                 |      | 27                  |      | nC             |
| $Q_{gls}^{(3)}$                     | Third-quadrant gate charge  | $V_{DS} < 0\text{V}$ , $V_{GS} = 10\text{V}$                                 |      | 64                  |      | nC             |
| $R_G$                               | Gate input resistance   | $f = 1\text{MHz}$ gate DC Bias = 0<br>Test signal level = 20mV<br>Open drain |      | 16                  |      | $\Omega$       |

1. Pulsed: pulse duration=300 $\mu\text{s}$ , duty cycle 1.5%

2.  $Q_{oss} = C_{oss} \cdot \Delta V_{in}$ ,  $C_{oss} = C_{gd} + C_{ds}$ . See [Section Appendix A](#)

3. Gate charge for synchronous operation

**Table 5. Switching times**

| Symbol       | Parameter           | Test conditions   | Min. | Typ. | Max. | Unit |
|--------------|---------------------|---|------|------|------|------|
| $t_{d(on)}$  | Turn-on delay time  | $V_{DD} = 10V, I_D = 40A,$<br>$R_G = 4.7\Omega, V_{GS} = 10V$<br><i>Figure 13 on page 8</i> |      | 14   |      | ns   |
| $t_r$        | Rise time           |   |      | 224  |      | ns   |
| $t_{d(off)}$ | Turn-off delay time |   |      | 69   |      | ns   |
| $t_f$        | Fall time           |   |      | 40   | 54   | ns   |

**Table 6. Source drain diode**

| Symbol         | Parameter                     | Test conditions   | Min | Typ. | Max | Unit    |
|----------------|-------------------------------|---|-----|------|-----|---------|
| $I_{SD}$       | Source-drain current          |   |     |      | 80  | A       |
| $I_{SDM}$      | Source-drain current (pulsed) |   |     |      | 320 | A       |
| $V_{SD}^{(1)}$ | Forward on voltage            | $I_{SD} = 40A, V_{GS} = 0$  |     |      | 1.3 | V       |
| $t_{rr}$       | Reverse recovery time         | $I_{SD} = 80A,$<br>$di/dt = 100A/\mu s,$<br>$V_{DD} = 15V, T_J = 150^\circ C$<br><i>Figure 15 on page 8</i> |     | 47   |     | ns      |
| $Q_{rr}$       | Reverse recovery charge       |   |     | 58   |     | $\mu C$ |
| $I_{RRM}$      | Reverse recovery current      |   |     | 2.5  |     | A       |

1. Pulsed: pulse duration=300 $\mu s$ , duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

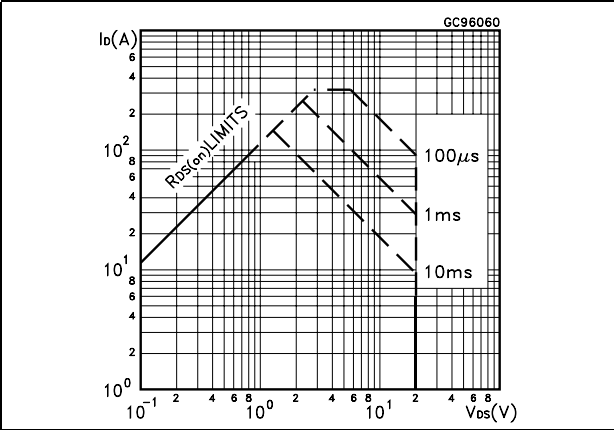


Figure 2. Thermal impedance

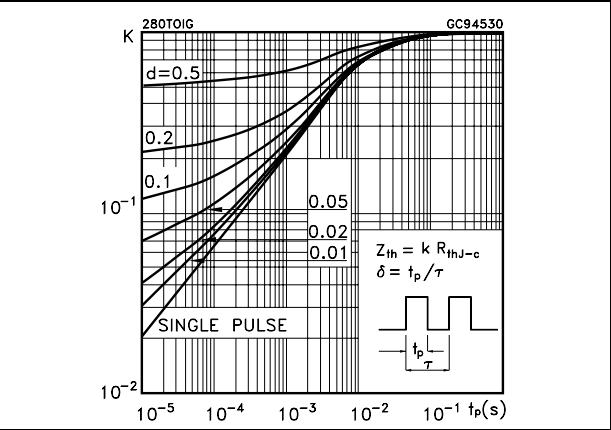


Figure 3. Output characteristics

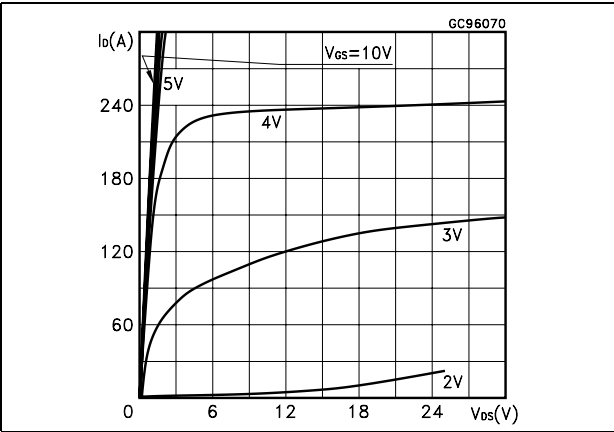


Figure 4. Transfer characteristics

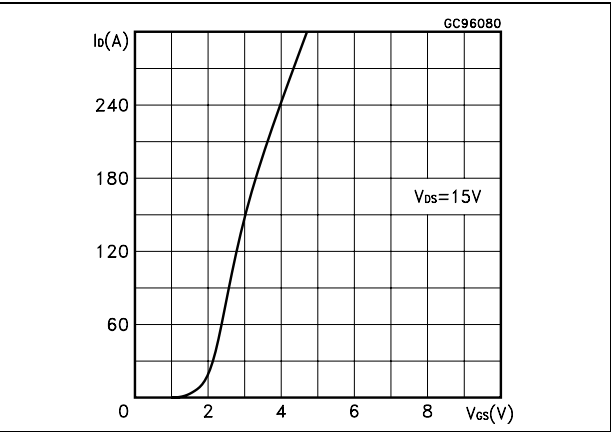


Figure 5. Transconductance

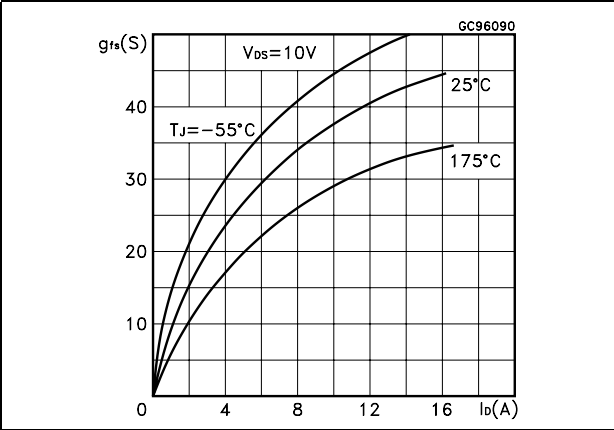


Figure 6. Static drain-source on resistance

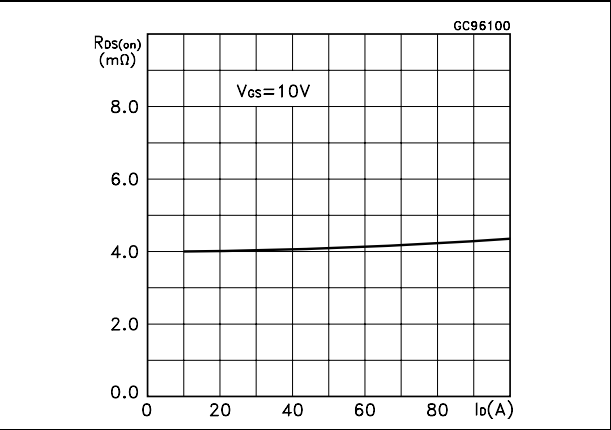


Figure 7. Gate charge vs gate-source voltage    Figure 8. Capacitance variations

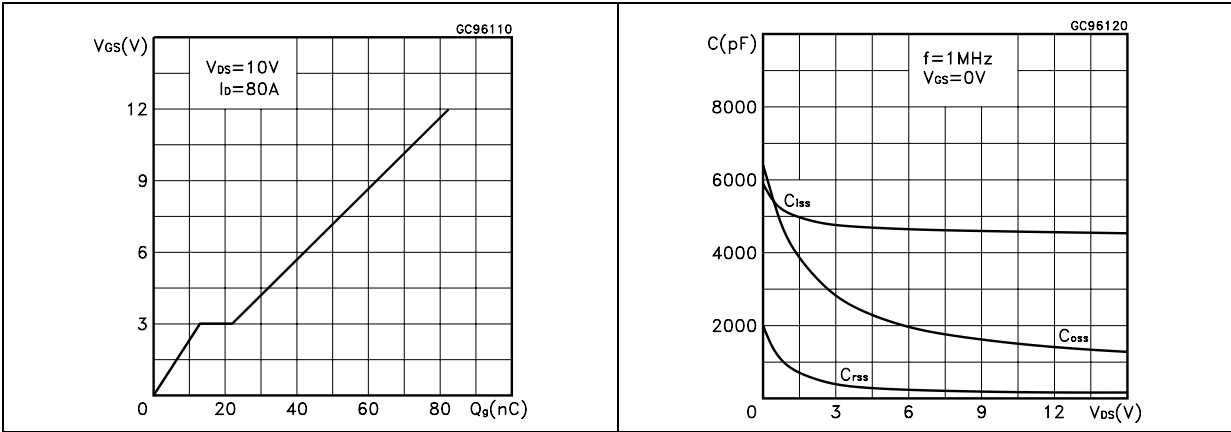


Figure 9. Normalized gate threshold voltage vs temperature    Figure 10. Normalized on resistance vs temperature

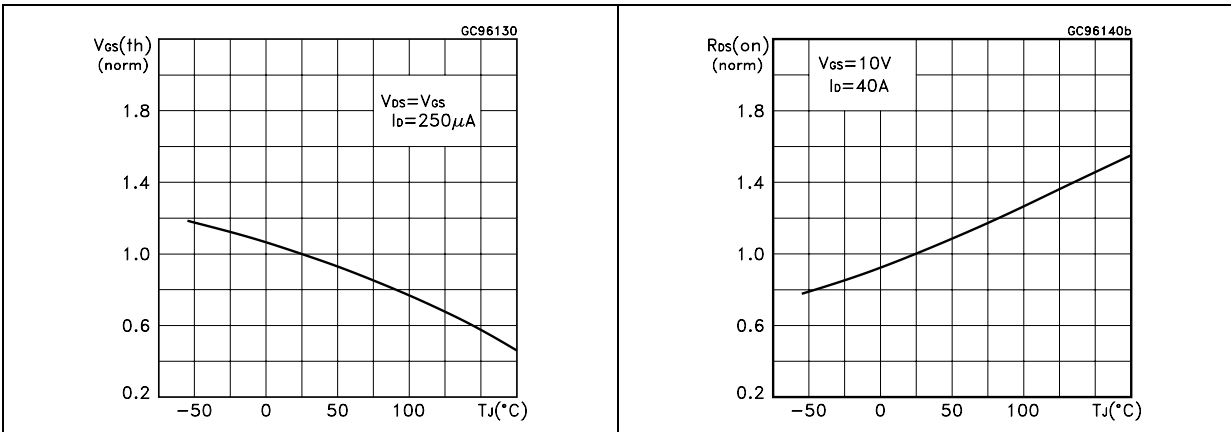
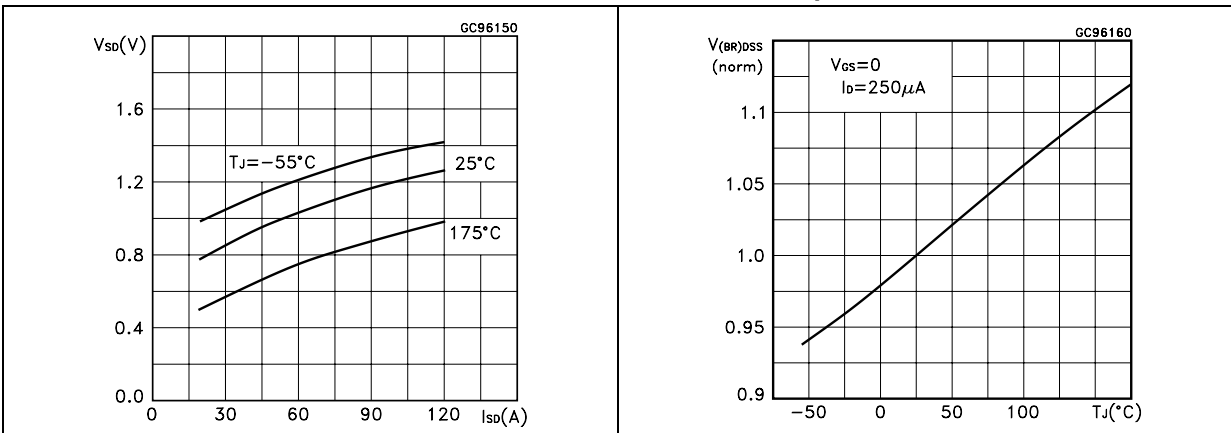


Figure 11. Source-drain diode forward characteristics    Figure 12. Normalized breakdown voltage vs temperature



### 3 Test circuit

Figure 13. Switching times test circuit for resistive load

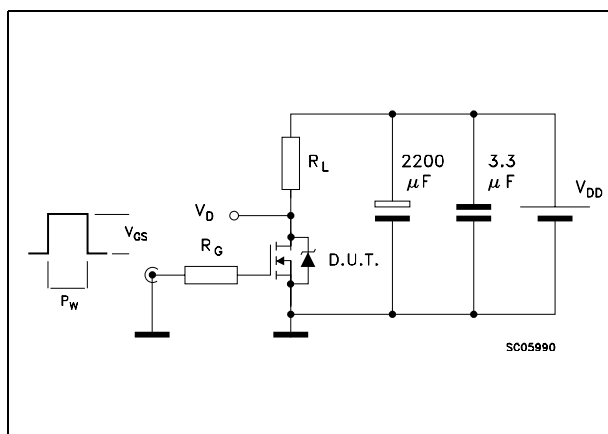


Figure 14. Gate charge test circuit

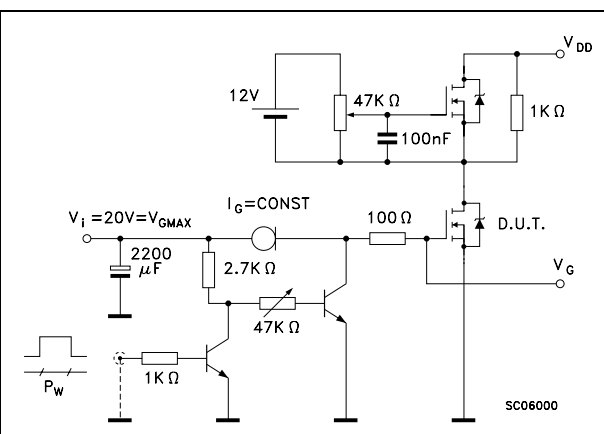


Figure 15. Test circuit for inductive load switching and diode recovery times

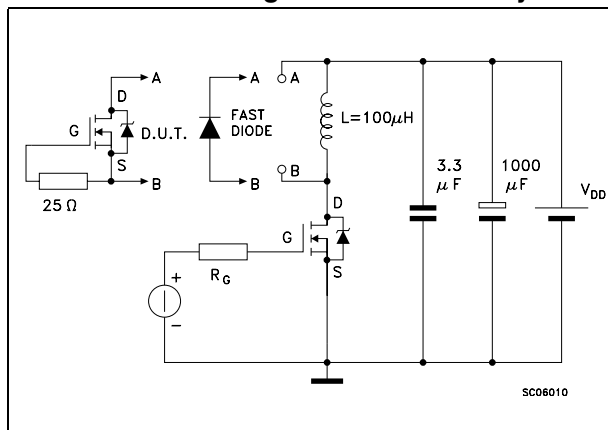


Figure 16. Unclamped Inductive load test circuit

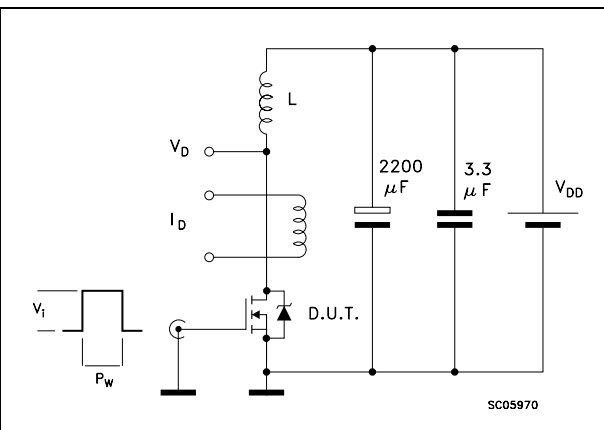
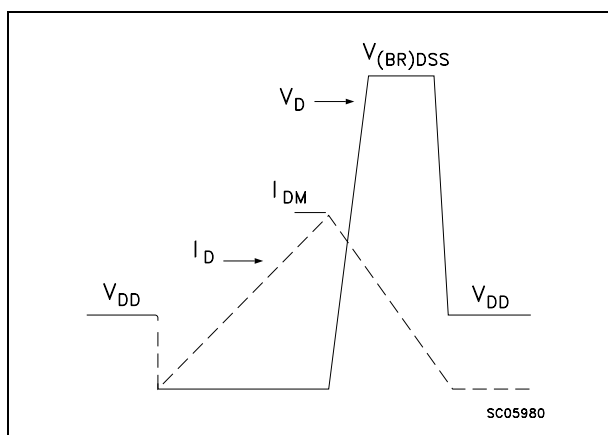


Figure 17. Unclamped inductive waveform





## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: [www.st.com](http://www.st.com)

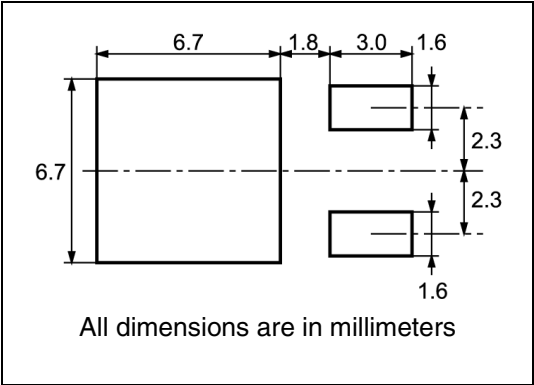
| DPAK MECHANICAL DATA |      |      |      |       |       |       |
|----------------------|------|------|------|-------|-------|-------|
| DIM.                 | mm.  |      |      | inch  |       |       |
|                      | MIN. | TYP  | MAX. | MIN.  | TYP.  | MAX.  |
| A                    | 2.2  |      | 2.4  | 0.086 |       | 0.094 |
| A1                   | 0.9  |      | 1.1  | 0.035 |       | 0.043 |
| A2                   | 0.03 |      | 0.23 | 0.001 |       | 0.009 |
| B                    | 0.64 |      | 0.9  | 0.025 |       | 0.035 |
| b4                   | 5.2  |      | 5.4  | 0.204 |       | 0.212 |
| C                    | 0.45 |      | 0.6  | 0.017 |       | 0.023 |
| C2                   | 0.48 |      | 0.6  | 0.019 |       | 0.023 |
| D                    | 6    |      | 6.2  | 0.236 |       | 0.244 |
| D1                   |      | 5.1  |      |       | 0.200 |       |
| E                    | 6.4  |      | 6.6  | 0.252 |       | 0.260 |
| E1                   |      | 4.7  |      |       | 0.185 |       |
| e                    |      | 2.28 |      |       | 0.090 |       |
| e1                   | 4.4  |      | 4.6  | 0.173 |       | 0.181 |
| H                    | 9.35 |      | 10.1 | 0.368 |       | 0.397 |
| L                    | 1    |      |      | 0.039 |       |       |
| (L1)                 |      | 2.8  |      |       | 0.110 |       |
| L2                   |      | 0.8  |      |       | 0.031 |       |
| L4                   | 0.6  |      | 1    | 0.023 |       | 0.039 |
| R                    |      | 0.2  |      |       | 0.008 |       |
| V2                   | 0°   |      | 8°   | 0°    |       | 8°    |

The mechanical drawing illustrates the STD110NH02L DPAK package. It includes a top view showing dimensions E, b4, L2, L4, H, e, e1, and b(2x). A side view shows dimensions A, c2, D, A1, c, and R. A detail view of the thermal pad shows dimensions E1, D1, and a thermal pad symbol. A circular detail view shows the seating plane, dimensions A2, L, (L1), V2, and a gauge plane with a 0.25 dimension.

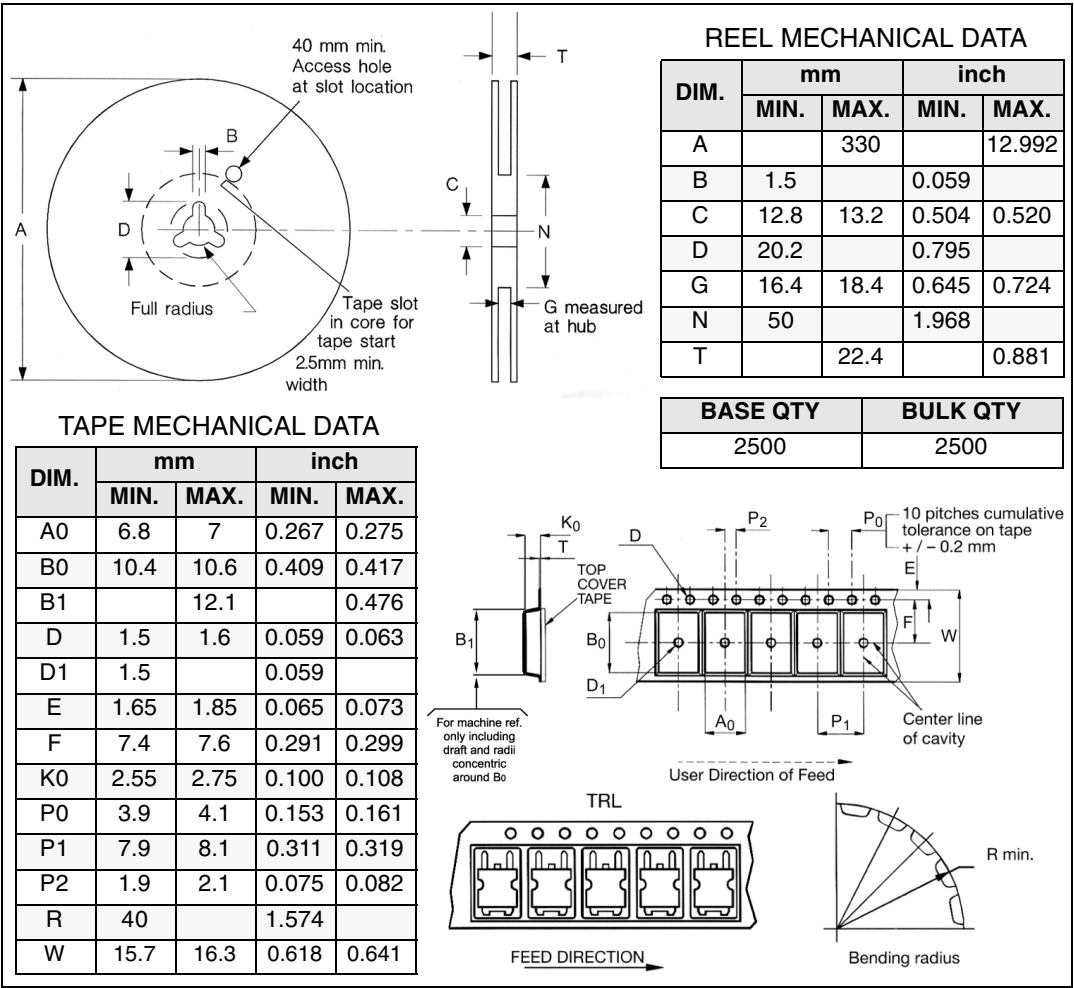
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# 5 Packaging mechanical data

## DPAK FOOTPRINT

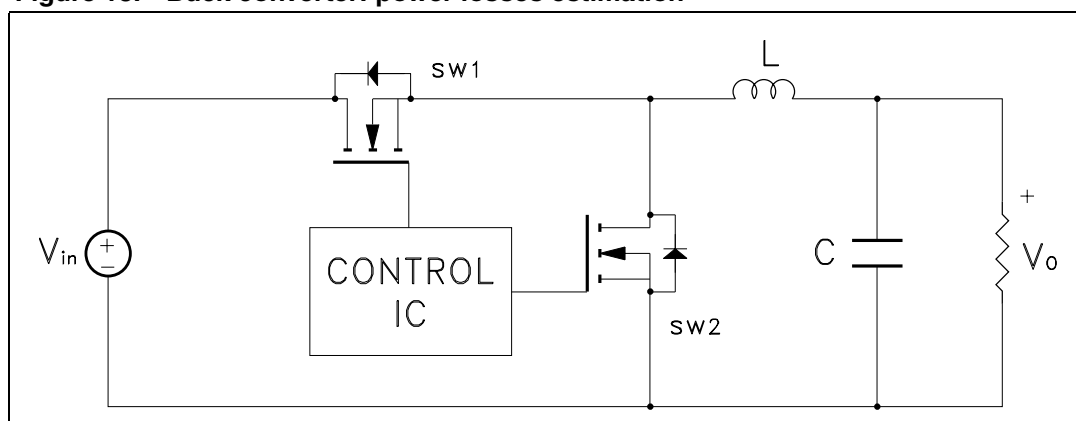


## TAPE AND REEL SHIPMENT



## Appendix A Buck converter - power losses estimation

Figure 18. Buck converter: power losses estimation



The power losses associated with the FETs in a synchronous buck converter can be estimated using the equations shown in the table below. The formulas give a good approximation, for the sake of performance comparison, of how different pairs of devices affect the converter efficiency. However a very important parameter, the working temperature, is not considered. The real device behavior is really dependent on how the heat generated inside the devices is removed to allow for a safer working junction temperature.

- The low side (SW2) device requires:
  - Very low  $R_{DS(on)}$  to reduce conduction losses
  - Small  $Q_{gl}$ s to reduce the gate charge losses
  - Small  $C_{oss}$  to reduce losses due to output capacitance
  - Small  $Q_{rr}$  to reduce losses on SW1 during its turn-on
  - The  $C_{gd}/C_{gs}$  ratio lower than  $V_{th}/V_{gg}$  ratio especially with low drain to source voltage to avoid the cross conduction phenomenon;
- The high side (SW1) device requires:
  - Small  $R_g$  and  $L_s$  to allow higher gate current peak and to limit the voltage feedback on the gate
  - Small  $Q_g$  to have a faster commutation and to reduce gate charge losses
  - Low  $R_{DS(on)}$  to reduce the conduction losses.

Table 7. Power losses calculation

|                        |                         | High side switching (SW1)                                      | Low side switch (SW2)                  |
|------------------------|-------------------------|--|--|
| Pconduction            |                         | $R_{DS(on)SW1} * I_L^2 * \delta$                               | $R_{DS(on)SW2} * I_L^2 * (1 - \delta)$ |
| Pswitching             |                         | $V_{in} * (Q_{gsth(SW1)} + Q_{gd(SW1)}) * f * \frac{I_L}{I_g}$ | Zero Voltage Switching                 |
| Pdiode                 | Recovery <sup>(1)</sup> | Not applicable   | $V_{in} * Q_{rr(SW2)} * f$             |
|                        | Conduction              | Not applicable   | $V_{f(SW2)} * I_L * t_{deadtime} * f$  |
| Pgate(Q <sub>G</sub> ) |                         | $Q_{g(SW1)} * V_{gg} * f$                                      | $Q_{gls(SW2)} * V_{gg} * f$            |
| P <sub>Qoss</sub>      |                         | $\frac{V_{in} * Q_{oss(SW1)} * f}{2}$                          | $\frac{V_{in} * Q_{oss(SW2)} * f}{2}$  |

1. Dissipated by SW1 during turn-on

Table 8. Paramiters meaning

| Parameter         | Meaning                                      |
|-------------------|--|
| d                 | Duty-cycle                                   |
| Q <sub>gsth</sub> | Post threshold gate charge                   |
| Q <sub>gls</sub>  | Third quadrant gate charge                   |
| Pconduction       | On state losses                              |
| Pswitching        | On-off transition losses                     |
| Pdiode            | Conduction and reverse recovery diode losses |
| Pgate             | Gate drive losses                            |
| P <sub>Qoss</sub> | Output capacitance losses                    |

## 6 Revision history

**Table 9. Revision history**

| Date        | Revision | Changes                   |
|-------------|----------|---------------------------|
| 09-Sep-2004 | 6        | Complete version          |
| 08-Aug-2006 | 7        | New template, updated SOA |

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